

<b>Notice of References Cited</b>	Application/Control No. 10/821,106		Applicant(s)/Patent Under Reexamination VIITAMAKI ET AL.	
	Examiner DAVID Q. NGUYEN		Art Unit 2617	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0040344	02-2003	Shteyn et al.	455/573
*	B	US-2004/0176065	09-2004	Liu, Bo	455/343.1
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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